

SANYO Semiconductors

DATA SHEET

An ON Semiconductor Company

N-Channel Silicon MOSFET

EFC4618R-P — General-Purpose Switching Device Applications

Features

- 2.5V drive
- · Best suited for LiB charging and discharging switch
- · Common-drain type
- · Protection diode in
- · Halogen free compliance

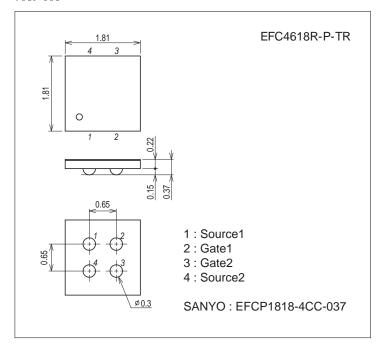
Specifications

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Conditions	Ratings	Unit
Source-to-Source Voltage	Vsss		24	V
Gate-to-Source Voltage	VGSS		±12	V
Source Current (DC)	Is		6	Α
Source Current (Pulse)	ISP	PW≤10μs, duty cycle≤1%	60	Α
Total Dissipation	PT	When mounted on ceramic substrate (5000mm ² ×0.8mm)	1.6	W
Channel Temperature	Tch		150	C
Storage Temperature	Tstg		-55 to +150	C

Package Dimensions

unit : mm (typ) 7069-001

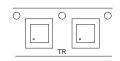


Product & Package Information

Package : EFCP JEITA, JEDEC : -

• Minimum Packing Quantity : 5,000 pcs./reel

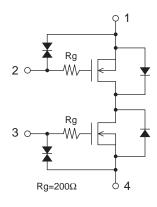
Packing Type: TR



Marking



Electrical Connection



EFC4618R-P

Electrical Characteristics at Ta=25°C

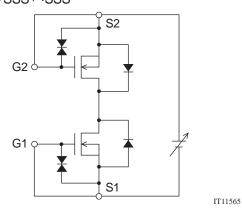
Parameter	Symbol Conditions		Ratings			Unit	
Falanietei	Syllibol	Conditions		min	typ	max	Offic
Source-to-Source Breakdown Voltage	V(BR)SSS	IS=1mA, VGS=0V	Test Circuit 1	24			V
Zero-Gate Voltage Source Current	ISSS	V _{SS} =20V, V _{GS} =0V	Test Circuit 1			1	μΑ
Gate-to-Source Leakage Current	IGSS	VGS=±8V, VSS=0V	Test Circuit 2			±10	μΑ
Cutoff Voltage	VGS(off)	VSS=10V, IS=1mA	Test Circuit 3	0.5		1.3	V
Forward Transfer Admittance	yfs	VSS=10V, IS=3A	Test Circuit 4		6.5		S
	Rss(on)1	IS=3A, VGS=4.5V	Test Circuit 5	13.5	19.8	23	$m\Omega$
	Rss(on)2	IS=3A, VGS=4.0V	Test Circuit 5	14	20.5	24	$m\Omega$
Static Source-to-Source On-State Resistance	Rss(on)3	IS=3A, VGS=3.7V	Test Circuit 5	14.5	21	25.5	mΩ
	Rss(on)4	IS=3A, VGS=3.1V	Test Circuit 5	14.9	23	30	mΩ
	Rss(on)5	IS=3A, VGS=2.5V	Test Circuit 5	18.5	27	35	$m\Omega$
Turn-ON Delay Time	t _d (on)				200		ns
Rise Time	t _r	See appoified Test Circuit	Test Circuit 7		815		ns
Turn-OFF Delay Time	t _d (off)	See specified Test Circuit.			1840		ns
Fall Time	tf				1770		ns
Total Gate Charge	Qg	VSS=10V, VGS=4.5V, IS=6A			25.4		nC
Forward Source-to-Source Voltage	VF(S-S)	I _S =3A, V _{GS} =0V	Test Circuit 6		0.76	1.2	V

Ordering Information

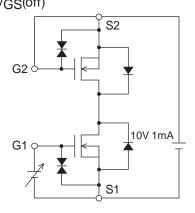
Device	Package	Shipping	memo
EFC4618R-P-TR EFCP		5,000pcs./reel	Pb Free and Halogen Free

Test circuits are example of measuring FET1 side



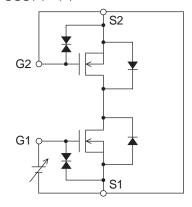


Test Circuit 3 VGS(off)



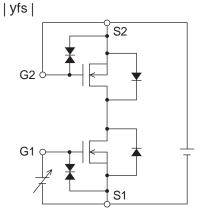
IT11567

Test Circuit 2 IGSS(+) / (--)

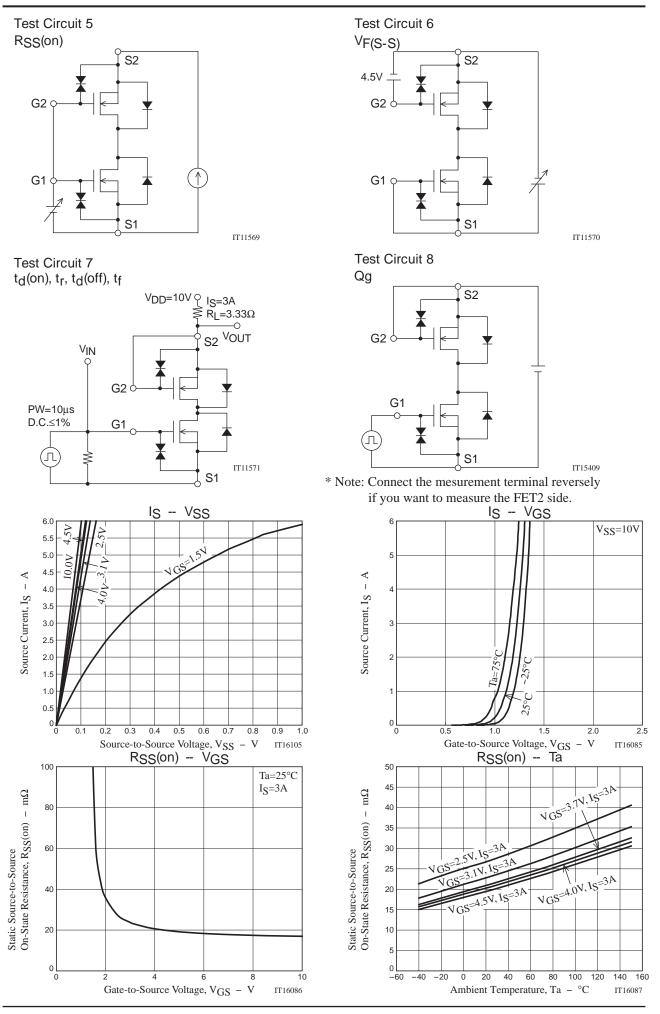


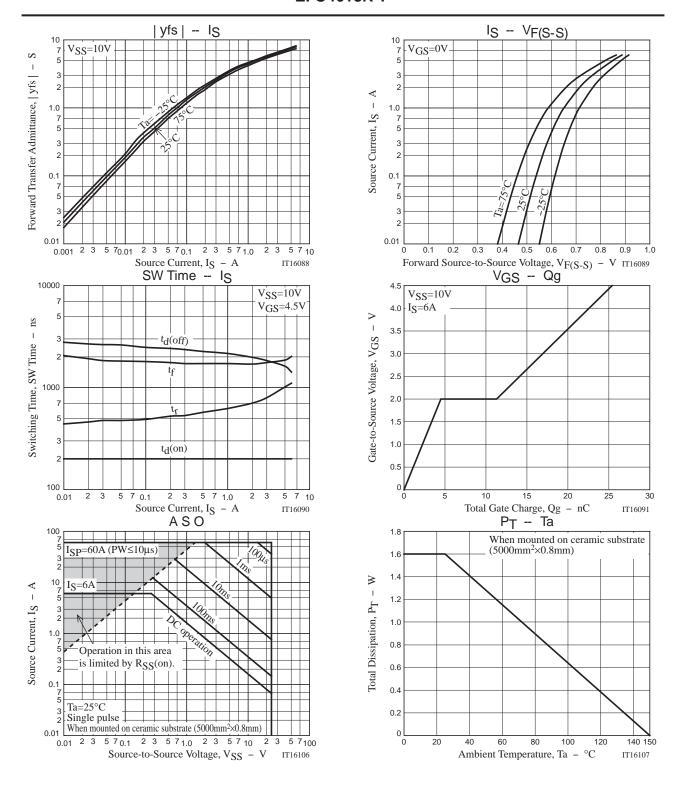
IT11566

Test Circuit 4



* Note: Connect the mesurement terminal reversely if you want to measure the FET2 side.



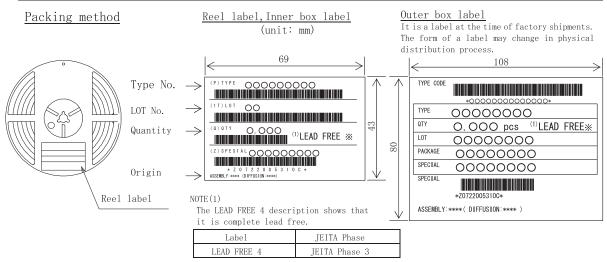


Taping Specification

EFC4618R-P-TR

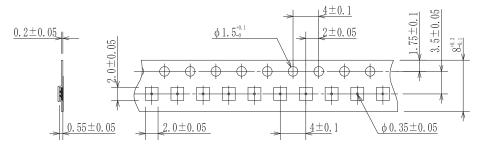
1. Packing Format

Package Name	Maximum Num	ber of devices c	ontained (pcs)	Packing format		
	Ree1	Inner box	Outer box	Inner BOX(C-1)	Outer BOX(A-7)	
EFCP1818-4CC-037	5,000	25, 000	150,000	5 reels contained	6 inner boxes contained	
				Dimensions :mm(external)	Dimensions :mm(external)	
				183 X 72 X 185	440 X 195 X 210	

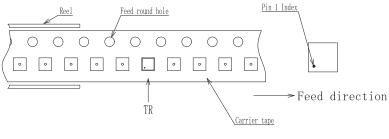


2. Taping configuration

2-1. Carrier tape size (unit: mm)



2-2. Device placement direction

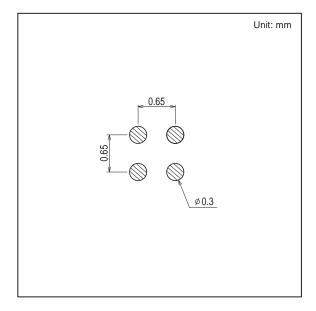


Packing type····TR

Outline Drawing

EFC4618R-P-TR

Land Pattern Example



Note on usage: Since the EFC4618R-P is a MOSFET product, please avoid using this device in the vicinity of highly charged objects.

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